2SD1511

Silicon NPN epitaxial planar type darlington

For low-frequency output amplification

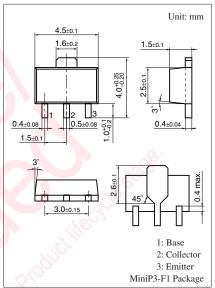
Features

- Forward current transfer ratio h_{FE} is designed high, which is appropriate to the driver circuit of motors and printer hammer: $h_{FE} = 4\,000$ to 20000.
- A shunt resistor is omitted from the driver.
- Mini power type package, allowing downsizing of the equipment and automatic insertion through the tape packing and the magazine packing.

Absolute Maximum Ratings $T_a = 25^{\circ}C$						
Parameter	Symbol	Rating	Unit			
Collector-base voltage (Emitter open)	V _{CBO}	100	V			
Collector-emitter voltage (Base open)	V _{CEO}	80	v			
Emitter-base voltage (Collector open)	V _{EBO}	5	V			
Collector current	I _C	1	А			
Peak collector current	I _{CP}	1.5	A			
Collector power dissipation *	P _C	1	W			
Junction temperature	Т	150	°CO			
Storage temperature	T _{stg}	-55 to +150	°C			

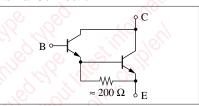
Absolute Maximum Ratings $T_a = 25^{\circ}C$

Note) *: Printed circuit board: Copper foil area of 1 cm² or more, and the board thickness of 1.7 mm for the collector portion



Marking Symbol: P

Internal Connection



Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V _{CBO}	$I_{\rm C} = 100 \ \mu {\rm A}, I_{\rm E} = 0$	100			V
Collector-emitter voltage (Base open)	V _{CEO}	$I_{\rm C} = 1 \text{ mA}, I_{\rm B} = 0$	80			V
Emitter-base voltage (Collector open)	V _{EBO}	$I_{\rm E} = 100 \ \mu A, I_{\rm C} = 0$	5			V
Collector-base cutoff current (Emitter open)	I _{CBO}	$V_{CB} = 25 \text{ V}, I_E = 0$			100	nA
Emitter-base cutoff current (Collector open)	I _{EBO}	$V_{EB} = 4 V, I_C = 0$			100	nA
Forward current transfer ratio *1, 2	h _{FE}	$V_{CE} = 10 \text{ V}, I_{C} = 1 \text{ A}$	4000		40 000	_
Collector-emitter saturation voltage *1	V _{CE(sat)}	$I_{C} = 1 A, I_{B} = 1 mA$			1.8	V
Base-emitter saturation voltage *1	V _{BE(sat)}	$I_{\rm C} = 1 \text{ A}, I_{\rm B} = 1 \text{ mA}$			2.2	V
Transition frequency	f _T	$V_{CB} = 10 \text{ V}, I_E = -50 \text{ mA}, f = 200 \text{ MHz}$		150		MHz

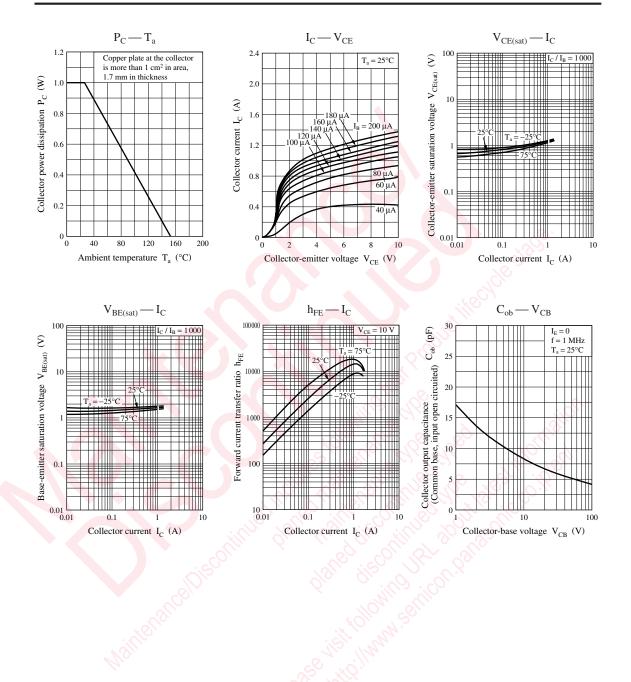
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. *1: Pulse measurement

*2: Rank classification

Rank	Q	R	S
\mathbf{h}_{FE}	4000 to 10000	8000 to 20000	16000 to 40000

Panasonic



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